

Application/Control No.	Applicant(s)/Patent under Reexamination
10/502.210	HAAS ET AL.
Examiner	Art Unit
Anish Desai	1771

SEARCHED					
Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
(DATE	EXMR		
Inventor search using EAST	7/7/2006	APD		
Text search using EAST	7/7/2006	APD		